

**Features**

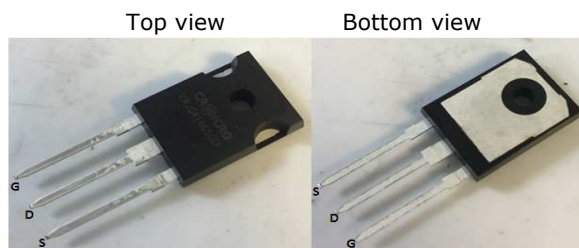
- CRM(CQ) Super\_Junction technology
- Much lower Ron\*A performance for On-state efficiency
- Much lower FOM for fast switching efficiency

**Applications**

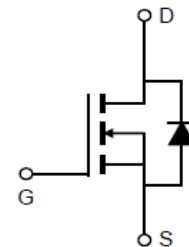
- LED/LCD/PDP TV and monitor Lighting
- Solar/Renewable/UPS-Micro Inverter System
- Charger
- Power Supply

**Product Summary**

VDS	650V
R <sub>DS(on)_typ</sub>	42mΩ
I <sub>D</sub>	85A

**100% DVDS Tested**
**100% Avalanche Tested**


CRJQ41N65GCF


**Package Marking and Ordering Information**

Part #	Marking	Package	Packing	Reel Size	Tape Width	Qty
CRJQ41N65GCF	-	TO-247-3L	Tube	N/A	N/A	25pcs

**Absolute Maximum Ratings**

Parameter	Symbol	Value	Unit
Drain-source voltage	V <sub>DS</sub>	650	V
Continuous drain current T <sub>C</sub> = 25°C T <sub>C</sub> = 100°C	I <sub>D</sub>	85 53	A
Pulsed drain current (T <sub>C</sub> = 25°C, t <sub>p</sub> limited by T <sub>jmax</sub> )	I <sub>D pulse</sub>	338	A
Avalanche energy, single pulse (L=30mH, Rg=30Ω)	E <sub>AS</sub>	1500	mJ
Gate-Source voltage	V <sub>GS</sub>	±30	V
Power dissipation (T <sub>C</sub> = 25°C)	P <sub>tot</sub>	687	W
Operating junction and storage temperature	T <sub>j</sub> , T <sub>stg</sub>	-55...+150	°C

**Thermal Resistance**

Parameter	Symbol	Value			Unit	Test Condition
		min.	typ.	max.		
Thermal resistance, junction - case. Max	RthJC	-	0.13	0.18	°C/W	
Thermal resistance, junction - ambient. Max	RthJA	-	-	45	°C/W	

**Electrical Characteristic (at T<sub>j</sub> = 25 °C, unless otherwise specified)**

Parameter	Symbol	Value			Unit	Test Condition
		min.	typ.	max.		

**Static Characteristic**

Drain-source breakdown voltage	BV <sub>DSS</sub>	650	-	-	V	V <sub>GS</sub> =0V, I <sub>D</sub> =250uA
Gate threshold voltage	V <sub>GS(th)</sub>	3.5	-	4.7	V	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250uA
Zero gate voltage drain current	I <sub>DSS</sub>	-	-	5	μA	V <sub>DS</sub> =650V, V <sub>GS</sub> =0V T <sub>C</sub> =25°C T <sub>C</sub> =150°C
		-	1000	-		
Gate-source leakage current	I <sub>GSS</sub>	-	-	±100	nA	V <sub>GS</sub> =±30V, V <sub>DS</sub> =0V
Drain-source on-state resistance	R <sub>DS(on)</sub>	-	42	48	mΩ	V <sub>GS</sub> =10V, I <sub>D</sub> =35A, T <sub>C</sub> =25°C T <sub>C</sub> =150°C
		-	110	-		
Transconductance	g <sub>fs</sub>	-	39	-	S	V <sub>DS</sub> =20V, I <sub>D</sub> =35A

**Dynamic Characteristic**

Input Capacitance	C <sub>iss</sub>	-	6215	9323	pF	V <sub>GS</sub> =0V, V <sub>DS</sub> =100V, f=1MHz
Output Capacitance	C <sub>oss</sub>	-	253	380		
Reverse Transfer Capacitance	C <sub>rss</sub>	-	43	86		
Gate Total Charge	Q <sub>G</sub>	-	168	252	nC	V <sub>GS</sub> =10V, V <sub>DS</sub> =480V, I <sub>D</sub> =35A, f=1MHz
Gate-Source charge	Q <sub>gs</sub>	-	57	86		
Gate-Drain charge	Q <sub>gd</sub>	-	88	176		
Turn-on delay time	t <sub>d(on)</sub>	-	179	-	ns	T <sub>j</sub> =25°C, V <sub>GS</sub> =10V, I <sub>D</sub> =35A, V <sub>DS</sub> =400V, R <sub>g</sub> =27Ω
Rise time	t <sub>r</sub>	-	115	-		
Turn-off delay time	t <sub>d(off)</sub>	-	312	-		
Fall time	t <sub>f</sub>	-	104	-		
Gate resistance	R <sub>G</sub>	-	1.0	2	Ω	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz

**Body Diode Characteristic**

Parameter	Symbol	Value			Unit	Test Condition
		min.	typ.	max.		
Body Diode Forward Voltage	$V_{SD}$	0.7	0.91	1.2	V	$V_{GS}=0V, I_{SD}=35A$
Body Diode Reverse Recovery Time	$t_{rr}$	-	194	388	ns	$I_{sd}=35A$ $dI/dt=100A/us, V_{ds}=400V$
Body Diode Reverse Recovery Charge	$Q_{rr}$	-	1.54	3.1	uC	

Typical Performance Characteristics

Fig 1. Output Characteristics (Tj=25°C)

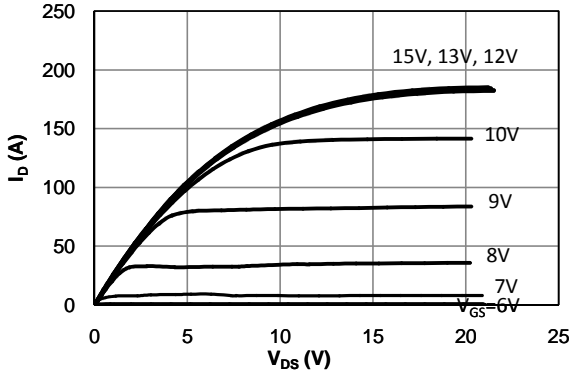


Fig 2. Output Characteristics (Tj=150°C)

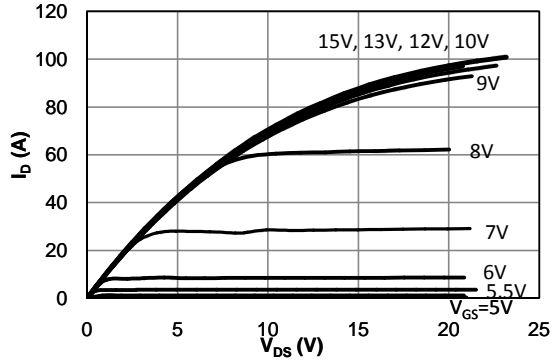


Fig 3: Transfer Characteristics

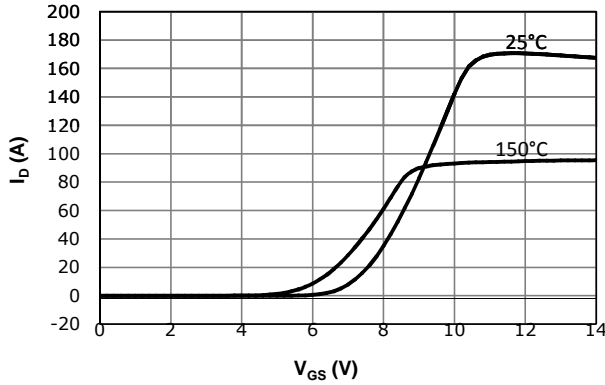


Fig 4:  $V_{TH}$  Vs  $T_j$  Temperature Characteristics

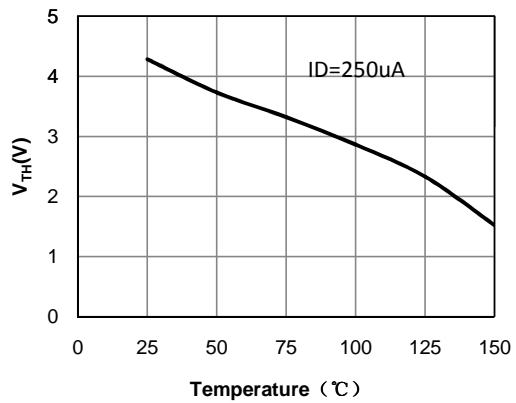


Fig 5:  $R_{DS(on)}$  Vs  $I_{DS}$  Characteristics (Tc=25°C)

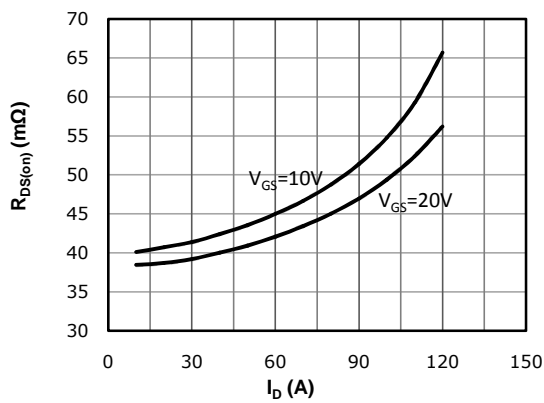
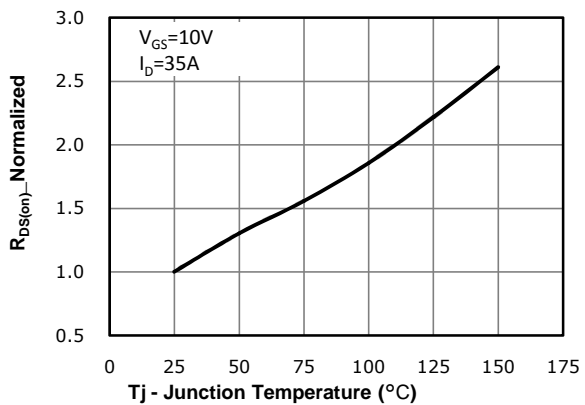
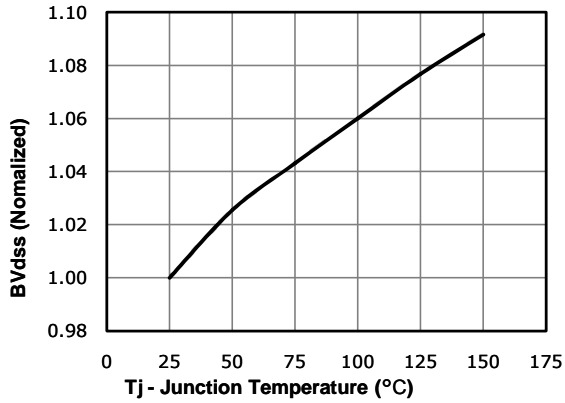


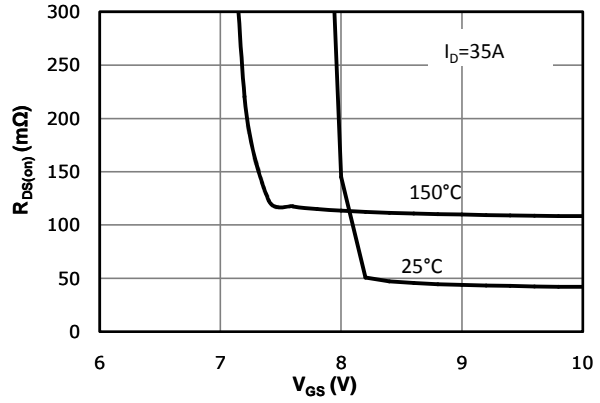
Fig 6:  $R_{DS(on)}$  vs. Temperature



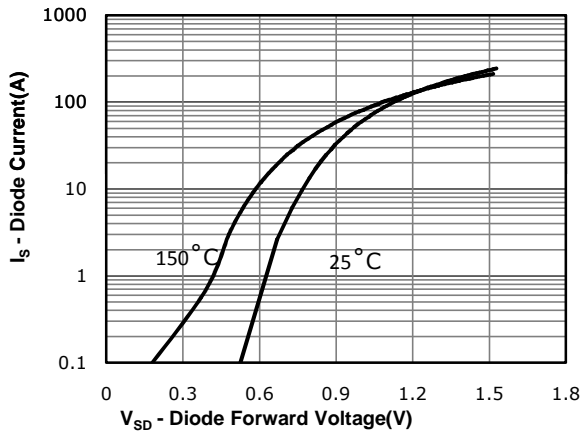
**Fig 7: BVdss vs. Temperature**



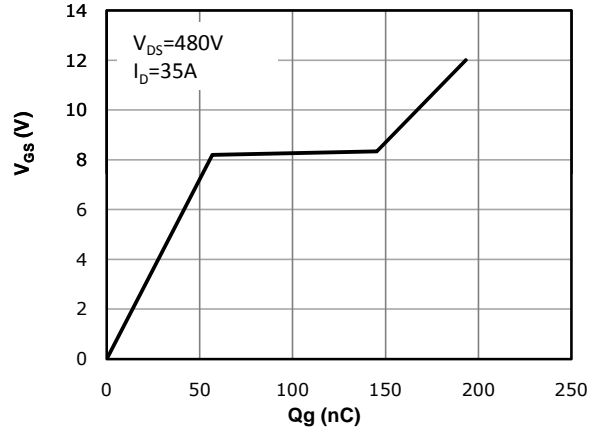
**Fig 8: Rds(on) vs Gate Voltage**



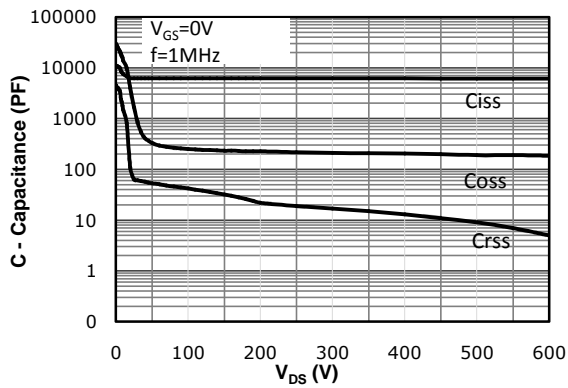
**Fig 9: Body-diode Forward Characteristics**



**Fig 10: Gate Charge Characteristics**



**Fig 11: Capacitance Characteristics**



**Fig 12: Safe Operating Area**

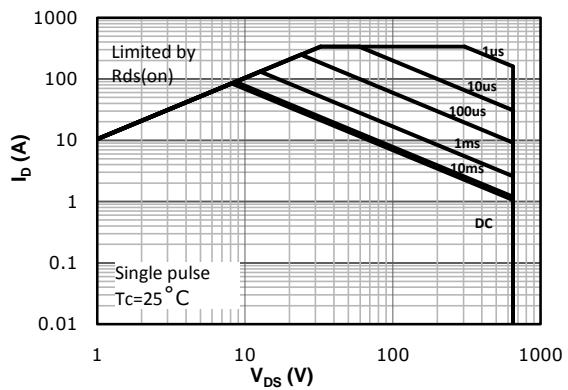
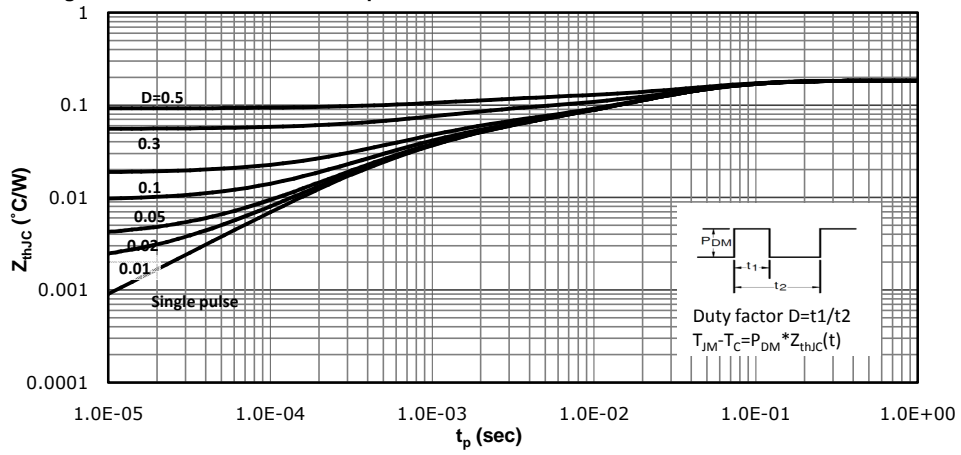
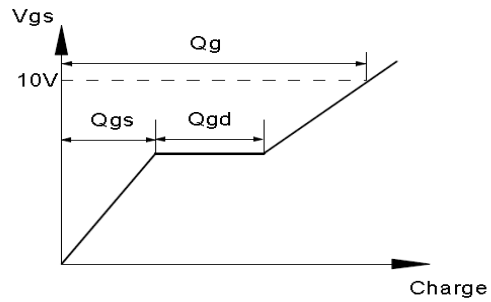
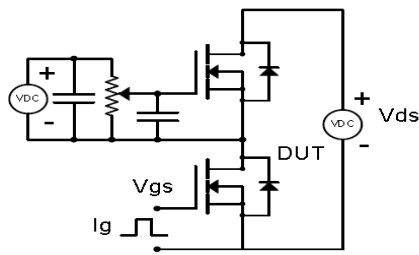


Fig 13: Max. Transient Thermal Impedance

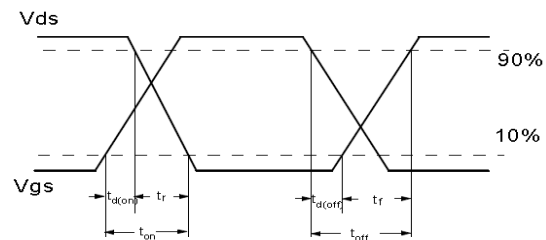
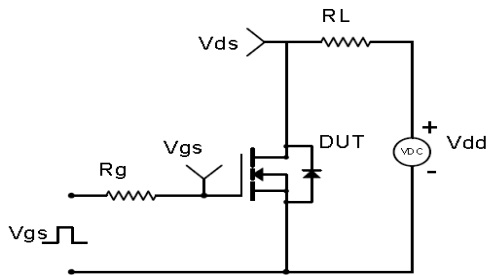


## Test Circuit & Waveform

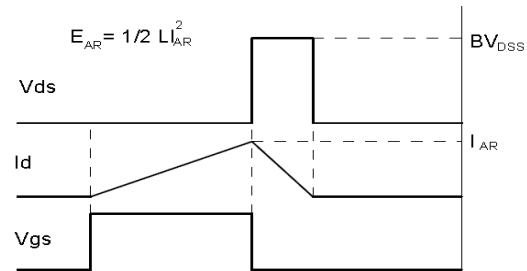
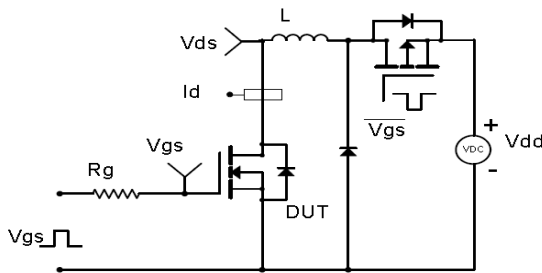
Gate Charge Test Circuit & Waveform



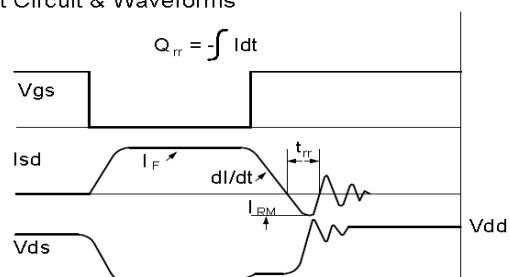
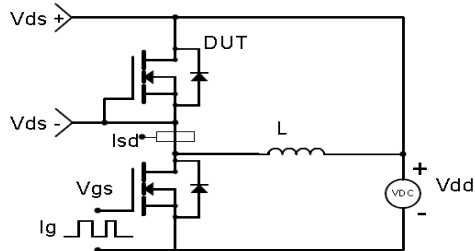
Resistive Switching Test Circuit & Waveforms

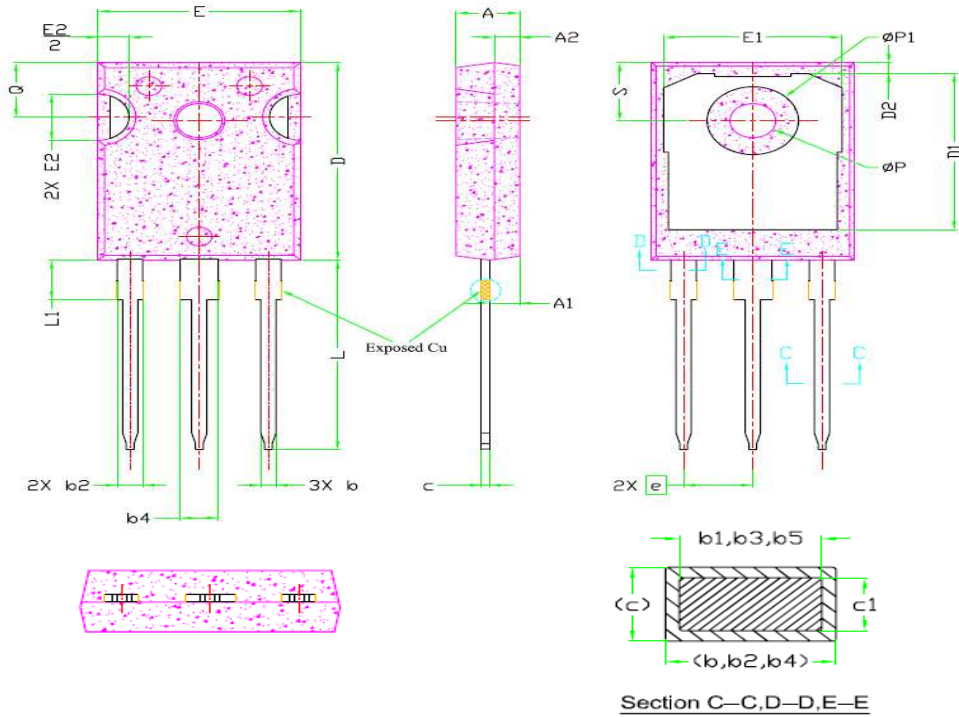


Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms



**Package Outline: TO-247-3L**


Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	4.83	5.21	0.190	0.205
A1	2.29	2.55	0.090	0.100
A2	1.50	2.49	0.059	0.098
b	1.12	1.33	0.044	0.052
b1	1.12	1.28	0.044	0.050
b2	1.91	2.39	0.075	0.094
b3	1.91	2.34	0.075	0.092
b4	2.87	3.22	0.113	0.127
b5	2.87	3.18	0.113	0.125
c	0.55	0.69	0.022	0.027
c1	0.55	0.65	0.022	0.026
D	20.80	21.10	0.819	0.831
D1	16.25	17.65	0.640	0.695
D2	0.51	1.35	0.020	0.053
E	15.75	16.13	0.620	0.635
E1	13.46	14.16	0.530	0.557
E2	4.32	5.49	0.170	0.216
e	5.44 BSC		0.21 BSC	
L	19.81	20.32	0.780	0.800
L1	4.10	4.40	0.161	0.173
ΦP	3.56	3.65	0.140	0.144
ΦP1	7.19 REF		0.28 REF	
Q	5.39	6.20	0.212	0.244
S	6.04	6.30	0.238	0.248



**Marking**



NOTE:  
 NXBBAAAAY  
 X       —Assembly location code  
 BB       —Fab code  
 AAAA   —Lot code  
 Y       —Bin code

**Revision History**

Revision	Date	Major changes
1.1	2020-8-14	Update package outline

**Disclaimer**

Unless otherwise specified in the datasheet, the product is designed and qualified as a standard commercial product and is not intended for use in applications that require extraordinary levels of quality and reliability, such as automotive, aviation/aerospace and life-support devices or systems.

Any and all semiconductor products have certain probability to fail or malfunction, which may result in personal injury, death or property damage. Customer are solely responsible for providing adequate safe measures when design their systems.

CRM(CQ) reserves the right to improve product design, function and reliability without notice.

单击下面可查看定价，库存，交付和生命周期等信息

[>>CRMICRO\(华润微\)](#)